


<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/809,153	KOIKE ET AL.	
	Examiner	Art Unit	
	Sean P. Shechtman	2125	

ISSUE CLASSIFICATION											
ORIGINAL				CROSS REFERENCE(S)							
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
700		121		700	19	23	96	97	99	103	114
INTERNATIONAL CLASSIFICATION				116	213						
G	0	6	F	19/00							
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Sean Shechtman 9/15/05 (Assistant Examiner) (Date)	<b>LEO PICARD</b> <b>SUPERVISORY PATENT EXAMINER</b> <b>TECHNOLOGY CENTER 2100</b>  (Primary Examiner) (Date) <i>L. P. Picard 9/16/05</i>	Total Claims Allowed: 29	
<i>C. Barnes 9/19/05</i> (Legal Instruments Examiner) (Date)		O.G. Print Claim(s) 18	O.G. Print Fig. 12

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant					<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
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